**Publisher's Note: Glassy Dynamics in Disordered Electronic
Systems Reveal Striking Thermal Memory Effects
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This Letter was published online on 6 September 2016 with an omission of a reference. On page 4, left-hand column, the last line of the third paragraph should read as "...distribution of relaxation rates is given by [32,2]". The new reference should read as "[32] A. Vaknin, Z. Ovadyahu, and M. Pollak, Phys. Rev. B 61, 6692 (2000)"; therefore, all references after [32] have been renumbered. The reference has been added as of 8 September 2016. The references and text are correct in the printed version of the journal.